

2SK2647-01MR

FUJI POWER MOSFET

N-CHANNEL SILICON POWER MOSFET

FAP-2S Series

■ Features

- High speed switching
- Low on-resistance
- No secondary breakdown
- Low driving power
- Avalanche-proof

■ Applications

- Switching regulators
- UPS (Uninterruptible Power Supply)
- DC-DC converters

■ Maximum ratings and characteristic

($T_c=25^\circ\text{C}$ unless otherwise specified)

Item	Symbol	Ratings	Unit
Drain-source voltage	V_{DS}	800	V
Continuous drain current	I_D	± 4	A
Pulsed drain current	$I_{D(\text{puls})}$	± 16	A
Gate-source voltage	V_{GS}	± 35	V
Repetitive or non-repetitive	I_{AR}^*	4	A
Maximum Avalanche Energy	E_{AS}^*	109	mJ
Max. power dissipation	P_D	40	W
Operating and storage temperature range	T_{ch}	+150	$^\circ\text{C}$
	T_{stg}	-55 to +150	$^\circ\text{C}$

*1 $L=12.5\text{mH}$, $V_{CC}=80\text{V}$ *2 $T_{ch}\leq 150^\circ\text{C}$

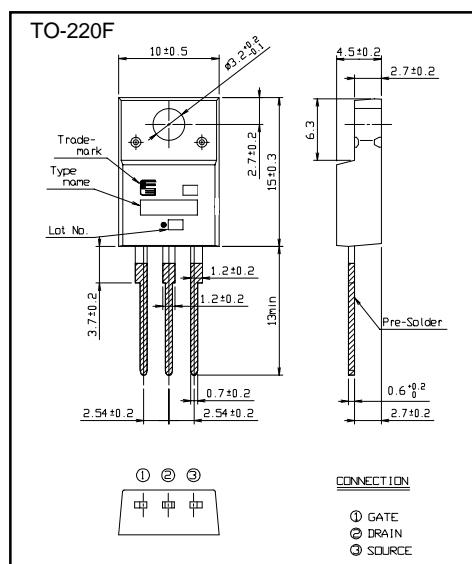
● Electrical characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain-source breakdown voltage	$V_{(BR)DSS}$	$I_D=1\text{mA}$ $V_{GS}=0\text{V}$	800			V
Gate threshold voltage	$V_{GS(\text{th})}$	$I_D=1\text{mA}$ $V_{DS}=V_{GS}$	3.5	4.0	4.5	V
Zero gate voltage drain current	I_{DSS}	$V_{DS}=800\text{V}$ $V_{GS}=0\text{V}$	10	500	500	μA
		$T_{ch}=25^\circ\text{C}$ $T_{ch}=125^\circ\text{C}$	0.2	1.0	1.0	mA
Gate-source leakage current	I_{GS}	$V_{GS}=\pm 35\text{V}$ $V_{DS}=0\text{V}$	10	100	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$I_D=2.0\text{A}$ $V_{GS}=10\text{V}$		3.19	4.0	Ω
Forward transconductance	g_{fs}	$I_D=2.0\text{A}$ $V_{DS}=25\text{V}$	1.0	2.0		S
Input capacitance	C_{iss}	$V_{DS}=25\text{V}$	450	680		pF
Output capacitance	C_{oss}	$V_{GS}=0\text{V}$	75	120		
Reverse transfer capacitance	C_{rss}	$f=1\text{MHz}$	40	60		
Turn-on time t_{on}	$t_{d(on)}$	$V_{CC}=600\text{V}$ $I_D=4\text{A}$	20	30		ns
	t_r	$V_{GS}=10\text{V}$	45	70		
Turn-off time t_{off}	$t_{d(off)}$	$R_{GS}=10\Omega$	50	80		
	t_f		30	50		
Avalanche capability	I_{AV}	$L=100\ \mu\text{H}$ $T_{ch}=25^\circ\text{C}$	4			A
Diode forward on-voltage	V_{SD}	$I_F=2xI_{DR}$ $V_{GS}=0\text{V}$ $T_{ch}=25^\circ\text{C}$		1.0	1.5	V
Reverse recovery time	t_{rr}	$I_F=I_{DR}$ $V_{GS}=0\text{V}$		700		ns
Reverse recovery charge	Q_{rr}	$-di/dt=100\text{A}/\mu\text{s}$ $T_{ch}=25^\circ\text{C}$		5.0		μC

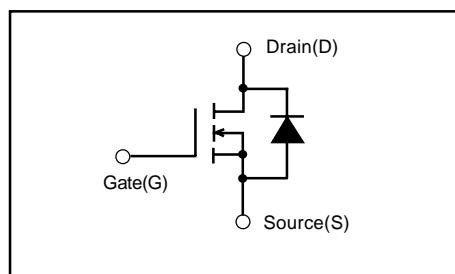
● Thermal characteristics

Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal resistance	$R_{th(ch-c)}$	channel to case			3.125	$^\circ\text{C}/\text{W}$
	$R_{th(ch-a)}$	channel to ambient			62.5	$^\circ\text{C}/\text{W}$

■ Outline Drawings



■ Equivalent circuit schematic



■ Characteristics

